Notice of References Cited Application/Control No. 10/653,556 Examiner Sara W. Crane Applicant(s)/Patent Under Reexamination BAEK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0238825	12-2004	Lim et al.	257/079
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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